Features
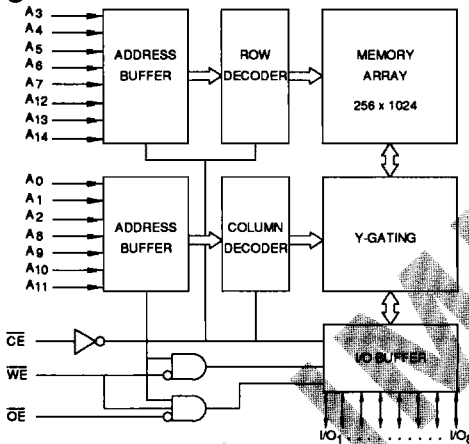
- **Low Power**
  25 mA Maximum (Active)
  30 µA Maximum (Standby)
- **3.3 V ± 10% Supply**
- **Fully Static: No Clock Required**
- **Two Control Inputs (CE and OE)**
- **TTL Compatible Inputs and Outputs**
- **28-Pin SOIC Surface Mount Packages**
- **JEDEC Pinout**

256K (32K x 8) Low Voltage CMOS SRAM

Preliminary

6

Block Diagram

Description

The AT38LV256 is a high performance CMOS static Random Access Memory. Its 256K of memory is organized as 32768 words by eight bits. Manufactured with an advanced CMOS technology, the AT38LV256 offers access times down to 70 ns. When the AT38LV256 is deselected, the standby current is just 30 µA.

The AT38LV256 powers down into the standby mode when deselected (CE is HIGH). The I/O pins remain in the high impedance state unless the chip is selected (CE is LOW), the outputs are enabled (OE is LOW), and Write Enable is not active (WE is HIGH).

The AT38LV256 is completely TTL compatible and requires a single 3.3-volt power supply. The device is fully static and does not need any clocks or refresh control signals for operation.

Pin Configurations

Pin Name	Function
A0-A14	Addresses
I/O1-I/O8	Outputs
CE	Chip Enable
OE	Output Enable
WE	Write Enable
Vcc, GND	Power, Ground

SOIC Top View

A14	1	28	VCC
A12	2	27	WE
A7	3	26	A13
A6	4	25	A8
A5	5	24	A9
A4	6	23	A11
A3	7	22	OE
A2	8	21	A10
A1	9	20	CE
A0	10	19	I/O8
I/O1	11	18	I/O7
I/O2	12	17	I/O6
I/O3	13	16	I/O5
GND	14	15	I/O4

Absolute Maximum Ratings*

Temperature Under Bias................. -55° C to 125° C

Storage Temperature...................... -65° C to 150° C

All Input Voltages
(including NC Pins)
with Respect to Ground .... -0.3 V$^{(1)}$ to V_{CC} + 0.3 V

All Output Voltages
with Respect to Ground .... -0.3 V$^{(1)}$ to V_{CC} + 0.3 V

Maximum Supply Voltage .... +7.0 V

Note:
1. Minimum input voltages are -3.5 V for pulse width less than 20 ns.

Device Operation

READ: When $\overline{CE}$ is LOW, $\overline{OE}$ is LOW, and $\overline{WE}$ is HIGH, the eight bits of data stored at the memory location determined by the address input (pins A_0 through A_{14}) are inserted on the data outputs (pins I/O$_1$ through I/O$_8$).

WRITE: When $\overline{CE}$ is LOW and $\overline{WE}$ is LOW, the eight bits of data placed on the input pins (I/O$_1$ through I/O$_8$) are stored at the memory location determined by the address input (pins A_0 through A_{14}).

Operating Modes

MODE\PIN	$\overline{CE}$	$\overline{OE}$	$\overline{WE}$	I/O
Read	L	L	H	D$_{OUT}$
Write	L	X$^{(1)}$	L	D$_{IN}$
Standby (Not Selected)	H	X	X	High Z
Output Disable (High Impedance)	X	H	X	High Z

Note: 1. X can be L (Low) or H (High)

D.C. and A.C. Operating Range

	AT38LV256
Operating Temperature (Ambient) Commercial	0°C - 70°C
V_{CC} Power Supply	3.3 V ± 10%

D.C. and Operating Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
I_{LI}	Input Load Current	V_{IN} = 0 to V_{CC}			2	µA
I_{LO}	Output Leakage Current	$\overline{CE}$ = 2.2 V to V_{CC} + 0.3 V or $\overline{OE}$ = 2.2 V to V_{CC} + 0.3 V or $\overline{WE}$ = -0.3 V to 0.8 V $V_{I/O}$ = 0 to V_{CC}			30	µA
I_{SB1}	Standby Current (CMOS)	$\overline{CE} \geq V_{CC}$ - 0.2 V, V_{IN} = (V_{CC} - 0.2 V) or ≤ 0.2 V			30	µA
I_{SB2}	Standby Current (TTL)	$\overline{CE}$ = 2.2 V to V_{CC} +0.3 V, V_{IN} = V_{IL} or V_{IH}			2.5	mA
I_{CC}	Vcc Active Current (TTL)	$\overline{CE}$ = -0.3 V to 0.5 V, I_{OUT} = 0 mA, min cycle			25	mA
V_{IL} [1]	Input Low Voltage		-0.3[2]		0.5	V
V_{IH} [1]	Input High Voltage		2.2 V		V_{CC} + 0.3	V
V_{OL}	Output Low Voltage	I_{OL} = 1.0 mA			0.4	V
V_{OH}	Output High Voltage	I_{OH} = -0.5 mA	2.4			V

Note: 1. These are voltages with repect to device GND.
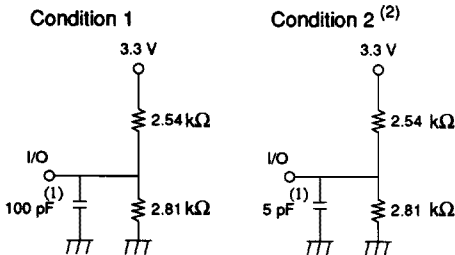   2. V_{IL} = -3.0 V for pulse width less than 20 ns.

Pin Capacitance   (f = 1 MHz, T = 25°C) [1]

Symbol	Parameter	Conditions	Min	Max	Units
C_{OUT}	Input/Output Capacitance	V_{OUT} = 0 V		10	pF
C_{IN}	Input Capacitance	V_{IN} = 0 V		10	pF

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.

Output Test Load
Figure 1

Item	Condition
Input pulse "High" level	V_{IH} = 3.0 V
Input pulse "Low" level	V_{IL} = 0 V
Input rise time	t_R = 5 ns
Input fall time	t_F = 5 ns
Input and output reference level	1.5 V
Output load	See Figure 1

Notes: 1. Capacitance Load includes scope and jig capacitances.
        2. For t_{COE}, t_{OOE}, t_{COD}, t_{OOD}, t_{WOE}, t_{WOD}.

A.C. Characteristics for Read

Symbol	Parameter	AT38LV256-70		AT38LV256-12		Units
		Min	Max	Min	Max	
t_{RC}	Read Cycle Time	70		120		ns
t_{ACC}	Address Access Time		70		120	ns
t_{CE}	CE Access Time		70		120	ns
t_{OE}	OE Access Time		35		60	ns
t_{OH}	Output Hold Time	10		10		ns
t_{COE} [1]	CE Output Enable Time	10		10		ns
t_{OOE} [1]	OE Output Enable Time	5		5		ns
t_{COD} [1]	CE Output Disable Time		30		40	ns
t_{OOD} [1]	OE Output Disable Time		30		40	ns

A.C. Characteristics for Write

| Symbol	Parameter	AT38LV256-70		AT38LV256-12		Units
		Min	Max	Min	Max	
t_{WC}	Write Cycle Time	70		120		ns
t_{AS}	Address Setup Time	0		0		ns
t_{WP}	Write Pulse Width	45		100		ns
t_{CW}	CE Setup Time	70		110		ns
t_{WR}	Write Recovery Time	5		5		ns
t_{DS}	Data Setup Time	30		70		ns
t_{DH}	Data Hold Time	0		0		ns
t_{WOE} [1]	WE Output Enable Time	10		10		ns
t_{WOD} [1]	WE Output Disable Time		30		40	ns

Note: 1. Transition is measured by ±500 mV from the normal state with the output test load circuit, condition 2.
This parameter is sampled and is not 100% tested.
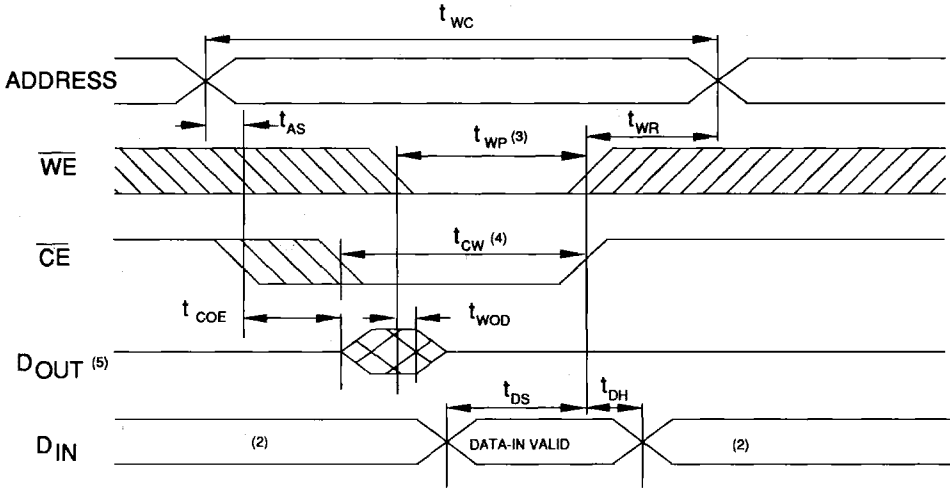
A.C. Waveforms for Read Cycle [1]
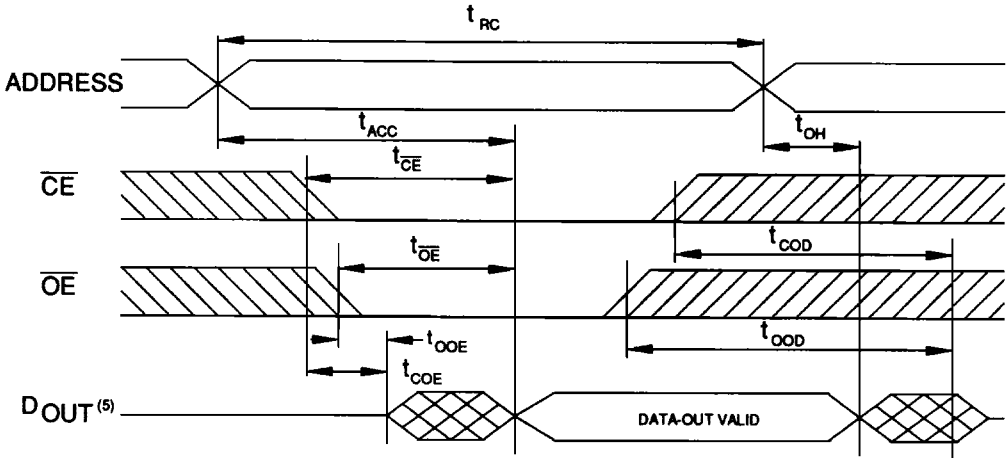
A.C. Waveforms for Write Cycle 1 ($\overline{\text{WE}}$ Write) [6]
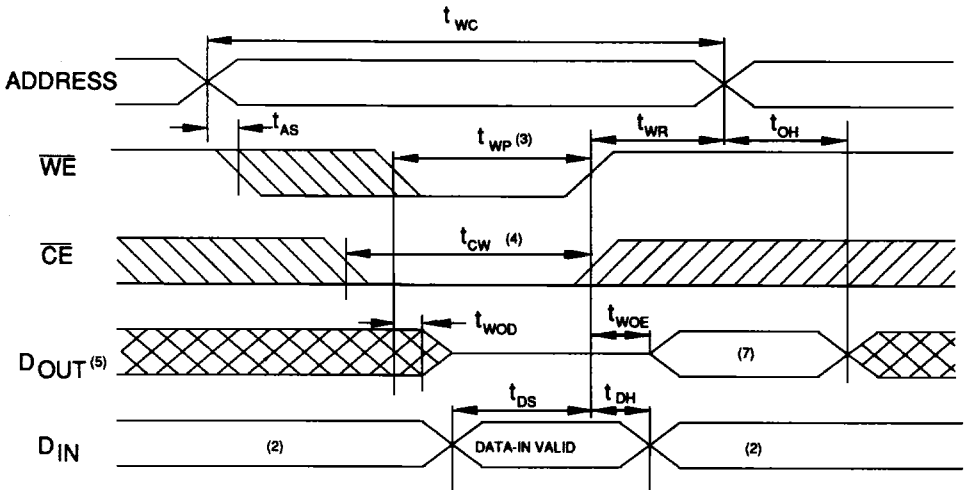
A.C. Waveforms for Write Cycle 2 ($\overline{WE}$ Write) [6]

Notes:
1. During a Read Cycle, $\overline{WE}$ should be HIGH.
2. During this period, I/O pins are in the output state.
3. A Write occurs when $\overline{CE}$ and $\overline{WE}$ are LOW at the same time. A Write begins at the latest transition among $\overline{CE}$ going LOW, and $\overline{WE}$ going LOW.
   A Write ends at the earliest transition among $\overline{CE}$ going HIGH, and $\overline{WE}$ going HIGH.
   t_{WP} is measured from the beginning of Write to the end of Write.
4. t_{CW} is measured from the later of $\overline{CE}$ going LOW or going HIGH to the end of Write.
5. If $\overline{CE}$ or $\overline{OE}$ is HIGH, or $\overline{WE}$ is LOW, D_{OUT} goes to a high impedance state.
6. During a write cycle, $\overline{OE} = V_{IH}$ or V_{IL}.
7. D_{OUT} is equal to the Input Data written during the same cycle.

AT38LV256

Ordering Information

tACC (ns)	Icc (mA)		Ordering Code	Package	Operation Range
	Active	Standby			
70	25	0.03	AT38LV256-70RC	28R	Commercial (0° to 70°C)
120	25	0.03	AT38LV256-12RC	28R	Commercial (0° to 70°C)

Package Type	
28R	28 Lead, 0.330" Wide, Plastic Gull Wing Small Outline (SOIC)